Form PTO 1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 264052US40PCT		SERIAL NO. 10/518,373	
(Modified)							
				APPLICANT			
LIST OF	REFE	RENCES CITED BY API	PLICANT	Kazushige OHNO, et al.			
				FILING DATE		GROUP	
				August 26, 2005		1724	
			1	U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	US 4,293,357	10/6/1981	Noboru HIGUCHI, et al.			
	AB	US 5,415,715	5/16/1995	André DELAGE, et al.			
	AC	US 5,497,620	3/12/1996	Per STOBBE			
	AD	US 5,573,919	11/12/1996	Kevin KEARNS, et al.			
	AE	US 5,693,230	12/2/1997	William J. ASHER			
	AF	US 6,165,244	12/26/2000	Kyung-Ju CHOI			
	AG	US 6,267,898 B1	7/31/2001	Tatsuya FUKUDA, et al.			
	АН	US 2001/0010153 A1	8/2/2001	Toshihiko SETOGUCHI, et al.			
	Al	US 6,387,144 B1	5/14/2002	Tadeusz JAROSZCZYK, et al.			
	AJ	US 2002/0078669 A1	6/27/2002	Kohei SHIMODA, et al.			
	AK	US 2003/0000188 A1	1/2/2003	Takashi HARADA, et al.			
	AL	US 2003/0089092 A1	5/15/2003	Daniel E. BAUSE, et al.			
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		DOCUMENT NUMBER DATE COUNTRY Japan (submitting English Abstract and unedited computer-generated English Translation only; previously filed 3/8/2005)			TRANSLATION YES NO		
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		OTHER RE	FERENCES (Including Author, Title, Date, Pertinent	Pages, e	tc.)	
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	AZ				Additional References sheet(s) attached		
Examiner					Date Considered		
*Examiner: Ir conformance	nitial if r	reference is considered, ot considered. Include co	whether or not ppy of this form	t citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lii	ne through	citation if not in
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